

<b>Notice of References Cited</b>	Application/Control No.	Applicant(s)/Patent Under Reexamination	
	09/753,184	BENDAK ET AL.	
	Examiner	Art Unit	
	David R Vincent	2661	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
A	US-6,671,271	12-2003	Takemura et al.	370/352
B	US-6,426,815	07-2002	Koehler, Steffen	398/59
C	US-6,529,303	03-2003	Rowan et al.	398/82
D	US-2003/0147585	08-2003	Kikuchi et al.	385/24
E	US-2002/0053062	05-2002	Szymanski, Ted	714/801
F	US-			
G	US-			
H	US-			
I	US-			
J	US-			
K	US-			
L	US-			
M	US-			

**FOREIGN PATENT DOCUMENTS**

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
N					
O					
P					
Q					
R					
S					
T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
U		
V		
W		
X		

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.